SDLS153

SN54LS292, SN54LS294, SN74LS292, SN74LS294
PROGRAMMABLE FREQUENCY DIVIDERS/DIGITAL TIMERS

D2628, JANUARY 1981 – REVISED MARCH 1988

- **Count Divider Chain**
- **Digitally Programmable from 2^2 to 2^n (n = 31 for 'LS292, n = 15 for 'LS294)**
- **Useable Frequency Range from DC to 30 MHz**
- **Easily Expandable**
- **Applications**
  - **Frequency Division**
  - **Digital Timing**

description

These programmable frequency dividers/digital timers contain 31 flip-flops plus 30 gates ('LS292) or 15 flip-flops plus 29 gates ('LS294) on a single chip. The count modulo is under digital control of the inputs provided.

Both types feature an active-low clear input to initialize the state of all flip-flops. To facilitate incoming inspection, test points are provided (TP1, TP2, and TP3 on the 'LS292 and TP on the 'LS294). These test points are not intended to drive system loads. Both types feature two clock inputs; either one may be used for clock gating. (See the function table below.)

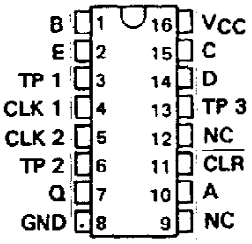
A brief look at the digital timing capabilities of the 'LS292 will show that with a 1-MHz input frequency, programming for 2^{10} will give a period of 1.024 ms, and 2^{20} will give a period of 1.05 sec, 2^{26} will give a period of 1.12 min, and 2^{31} will give a period of 35.79 min.

These devices are easily cascadable giving limitless possibilities to timing delays that can be achieved.

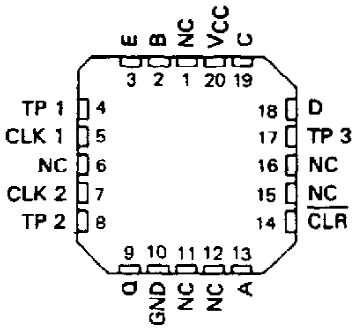
FUNCTION TABLE

CLEAR	CLK 1	CLK 2	Q OUTPUT MODE
L	X	X	Cleared to L
H	↑	L	Count
H	L	↑	Count
H	H	X	Inhibit
H	X	H	Inhibit

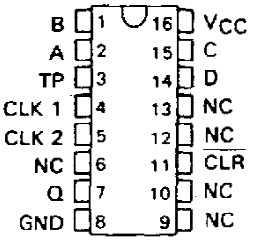
SN54LS292 . . . J OR W PACKAGE
SN74LS292 . . . N PACKAGE
(TOP VIEW)



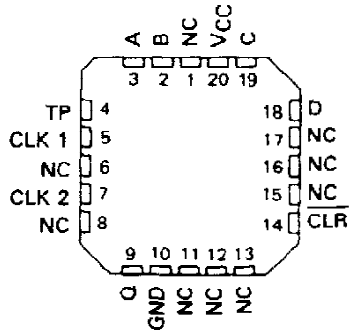
SN54LS292 . . . FK PACKAGE
(TOP VIEW)



SN54LS294 . . . J OR W PACKAGE
SN74LS294 . . . N PACKAGE
(TOP VIEW)



SN54LS294 . . . FK PACKAGE
(TOP VIEW)



NC – No internal connection.

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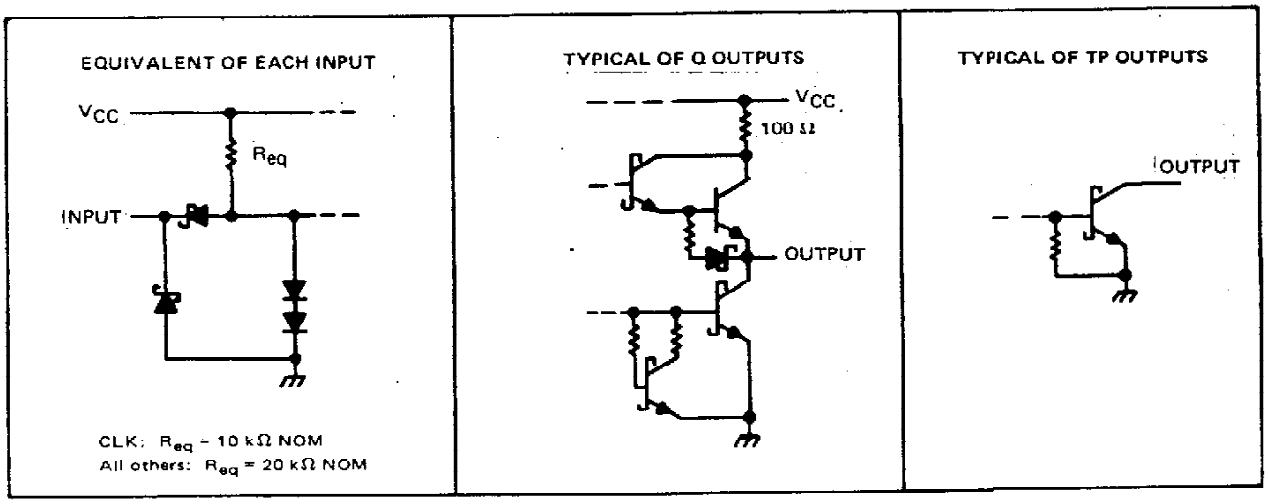
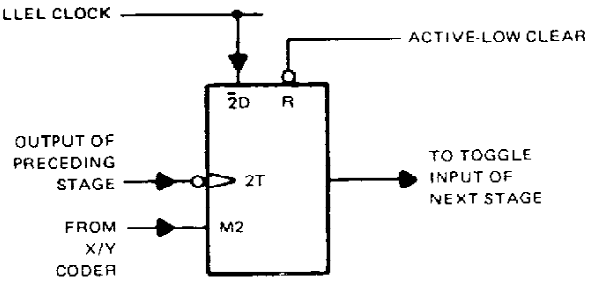
schematics of inputs and outputs



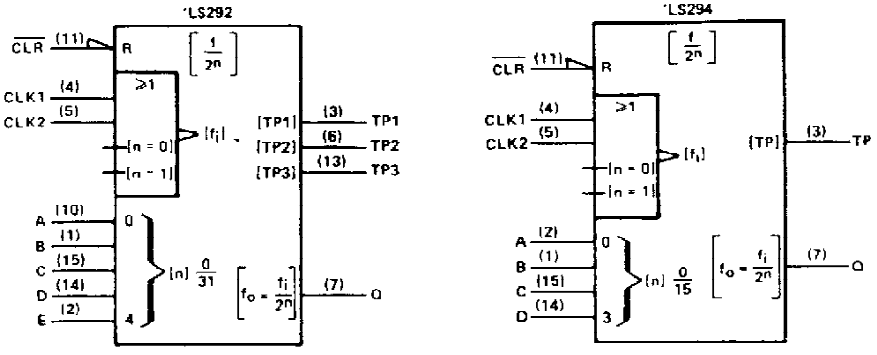
operation

The functional block diagram shows that the count modulo is controlled by an X/Y decoder connected to the mode control inputs of several flip-flops. These flip flops with mode controls each have a "D" input connected to the parallel clock line and a "T" input driven by the preceding stage. The parallel clock frequency is always the input frequency divided by four.

The X/Y decoder output selected by the programming inputs goes low. While a mode control is low, the "D" input of that flip-flop is enabled, and the signal from the parallel clock line ($f_{in} \div 4$) is passed to the "T" input of the following stage. All the other mode controls are high enabling the "T" inputs and causing each flip-flop in turn to divide by two.



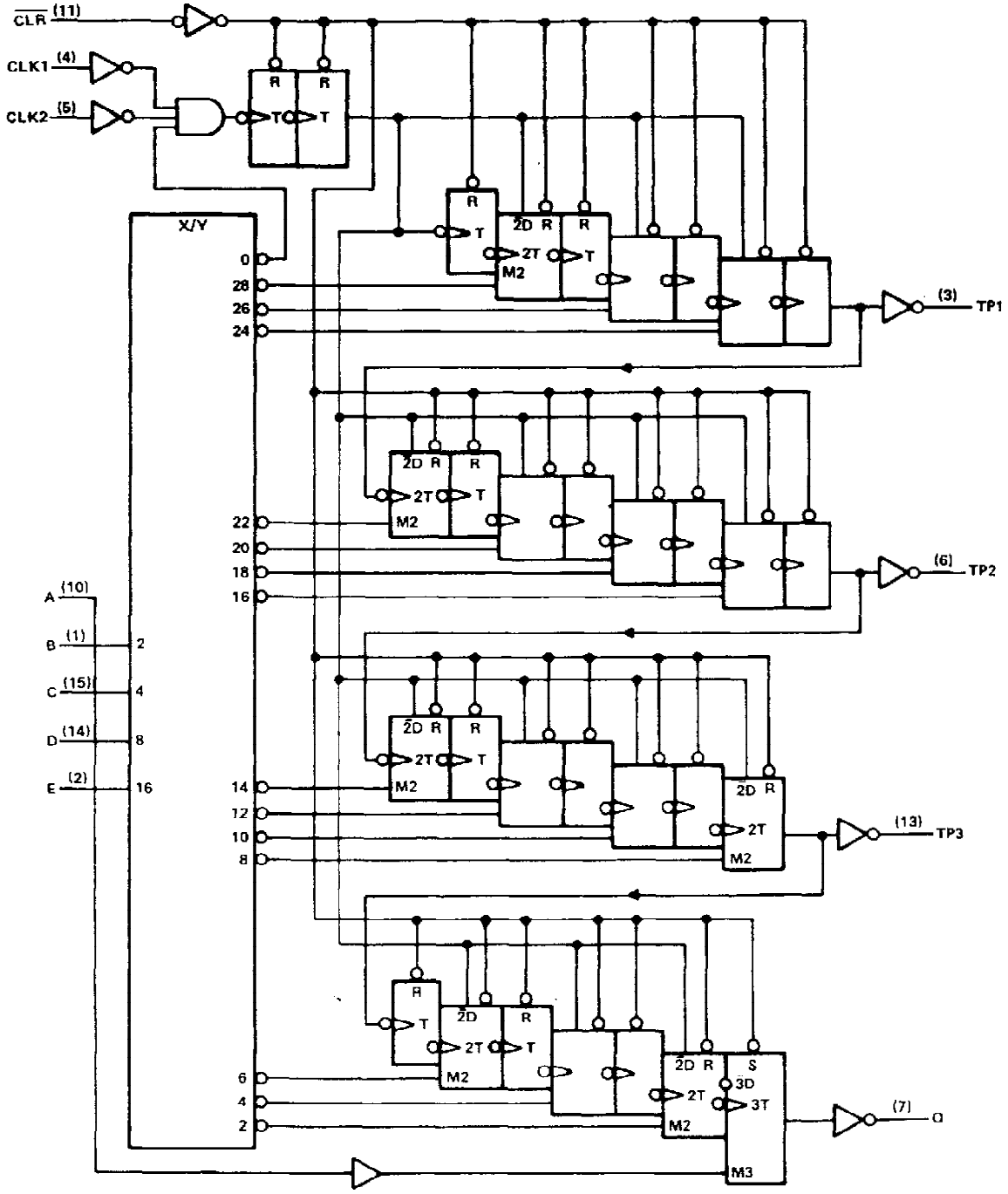
logic symbols†



†These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
Pin numbers shown are for J, N, and W packages.

logic diagram (positive logic)

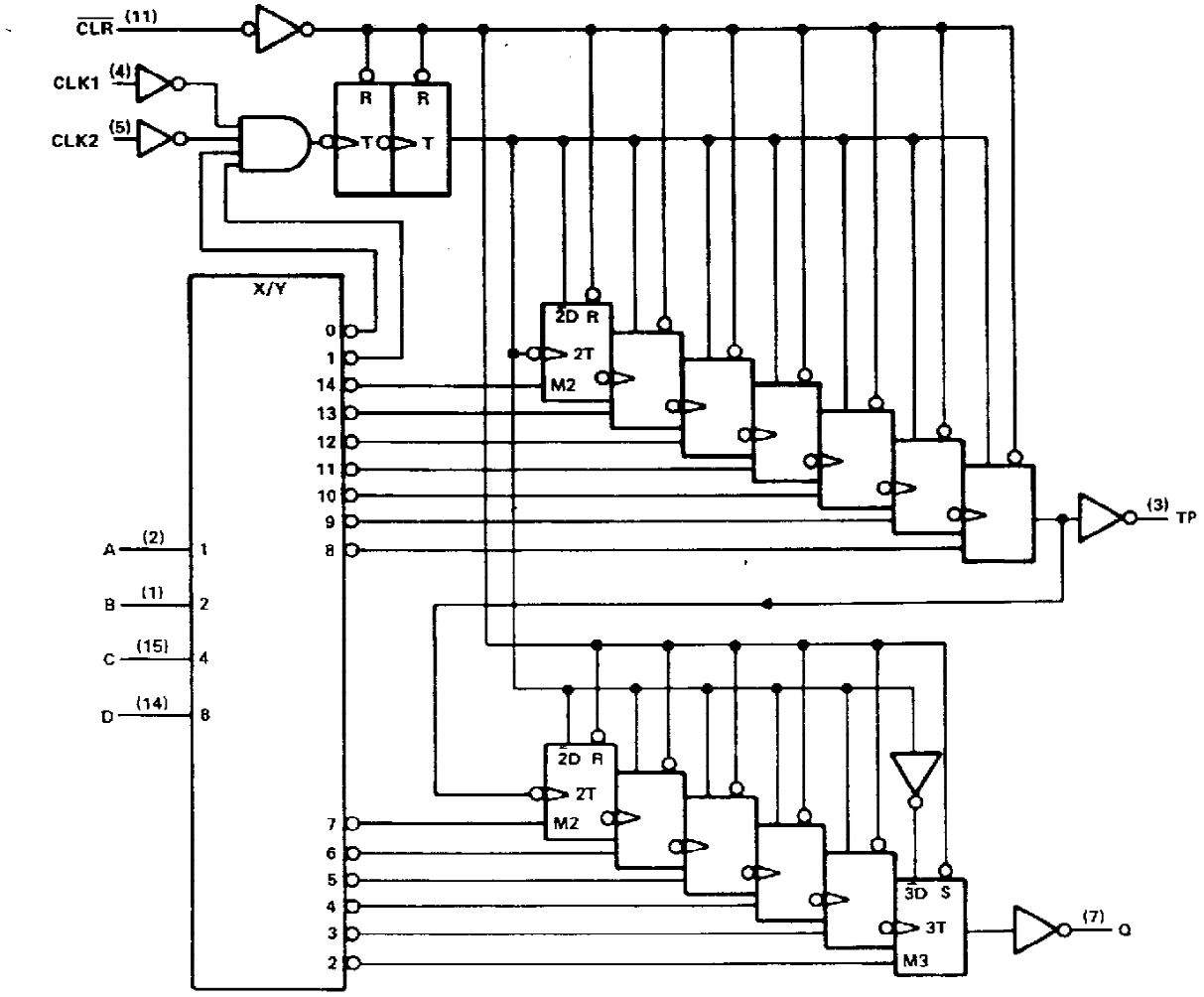
'LS292



Pin numbers shown are for J, N, and W packages.

logic diagram (positive logic)

'LS294



Pin numbers shown are for J, N, and W packages.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1)		7 V
Input voltage		7 V
Operating free-air temperature range:	SN54LS292, SN54LS294	−55°C to 125°C
	SN74LS292, SN74LS294	0°C to 70°C
Storage temperature range		−65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

			SN54LS'			SN74LS'			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage		4.5	5	5.5	4.75	5	5.25	V
V_{IH}	High-level input voltage		2			2			V
V_{IL}	Low-level input voltage				0.7			0.8	V
I_{OH}	High-level output current (Q only)				−1.2			−1.2	mA
I_{OL}	Low-level output current (Q only)				12			24	mA
f_{clock}	Clock frequency		0		30	0		30	MHz
t_w	Duration of clock input pulse		16			16			ns
t_w	Duration of clear pulse	'LS292	55			55			ns
		'LS294	35			35			
t_{su}	Clear inactive-state setup time		15			15			ns
T_A	Operating free-air temperature		−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†		SN54LS'			SN74LS'			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}		V_{CC} = MIN, I_I = −18 mA				−1.5			−1.5	V
V_{OH}	Q	V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = MAX	I_{OH} = −1.2 mA,	2.4	3.4		2.4	3.4		V
V_{OL}	Q	V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = MAX	I_{OL} = 12 mA		0.25	0.4		0.25	0.4	V
	TP¶		I_{OL} = 24 mA					0.35	0.5	
			I_{OL} = 0.5 mA					0.25	0.4	
I_I		V_{CC} = MAX, V_I = 7 V				0.1			0.1	mA
I_{IH}		V_{CC} = MAX, V_I = 2.7 V				20			20	μA
I_{IL}	CLK1, CLK2	V_{CC} = MAX, V_I = 0.4 V				−0.8			−0.8	mA
	All others					−0.4			−0.4	
I_{OS}§	Q	V_{CC} = MAX		−30		−130	−30		−130	mA
I_{CC}	'LS292	V_{CC} = MAX, All inputs grounded, All outputs open			40	75		40	75	mA
	'LS294				30	50		30	50	

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.
§ The duration of the short-circuit should not exceed one second.
¶ The TP output or outputs are not intended to drive external loads but are solely provided for test points.

switching characteristics, V_{CC} = 5 V, T_A = 25°C, R_L = 667 Ω, C_L = 45 pF (see Figure 1)

PARAMETER†	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	'LS292			'LS294			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
f_{max}	CLK1 or 2			30	50		30	50		MHz
t_{PLH}	CLK1 or 2	Q	Modulo set at 22, A thru E = LLLHL ('LS292) A thru D = LLHL ('LS294)		55	90		55	90	ns
t_{PHL}	CLK1 or 2	Q	Modulo set at 22, A thru E = LLLHL ('LS292) A thru D = LLHL ('LS294)		80	120		80	120	ns
t_{PHL}	$\overline{CLR}$	Q			85	130		35	65	ns

†f_{MAX} = maximum clock frequency
t_{PLH} = Propagation delay time, low-to-high-level output
t_{PHL} = Propagation delay time, high-to-low-level output
NOTE 2: Load circuits and voltage waveforms are shown in Section 1. To be used on TP outputs only.

'LS292 FUNCTION TABLE

PROGRAMMING INPUTS					FREQUENCY DIVISION							
					Q		TP1		TP2		TP3	
E	D	C	B	A	BINARY	DECIMAL	BINARY	DECIMAL	BINARY	DECIMAL	BINARY	DECIMAL
L	L	L	L	L	Inhibit	Inhibit	Inhibit	Inhibit	Inhibit	Inhibit	Inhibit	Inhibit
L	L	L	L	H	Inhibit	Inhibit	Inhibit	Inhibit	Inhibit	Inhibit	Inhibit	Inhibit
L	L	L	H	L	2^2	4	2^9	512	2^{17}	131,072	2^{24}	16,777,216
L	L	L	H	H	2^3	8	2^9	512	2^{17}	131,072	2^{24}	16,777,216
L	L	H	L	L	2^4	16	2^9	512	2^{17}	131,072	2^{24}	16,777,216
L	L	H	L	H	2^5	32	2^9	512	2^{17}	131,072	2^{24}	16,777,216
L	L	H	H	L	2^6	64	2^9	512	2^{17}	131,072	2^{24}	16,777,216
L	L	H	H	H	2^7	128	2^9	512	2^{17}	131,072	2^{24}	16,777,216
L	H	L	L	L	2^8	256	2^9	512	2^{17}	131,072	2^2	4
L	H	L	L	H	2^9	512	2^9	512	2^{17}	131,072	2^2	4
L	H	L	H	L	2^{10}	1,024	2^9	512	2^{17}	131,072	2^4	16
L	H	L	H	H	2^{11}	2,048	2^9	512	2^{17}	131,072	2^4	16
L	H	H	L	L	2^{12}	4,096	2^9	512	2^{17}	131,072	2^6	64
L	H	H	L	H	2^{13}	8,192	2^9	512	2^{17}	131,072	2^6	64
L	H	H	H	L	2^{14}	16,384	2^9	512	Disabled Low		2^8	256
L	H	H	H	H	2^{15}	32,768	2^9	512	Disabled Low		2^8	256
H	L	L	L	L	2^{16}	65,536	2^9	512	2^3	8	2^{10}	1,024
H	L	L	L	H	2^{17}	131,072	2^9	512	2^3	8	2^{10}	1,024
H	L	L	H	L	2^{18}	262,144	2^9	512	2^5	32	2^{12}	4,096
H	L	L	H	H	2^{19}	524,288	2^9	512	2^5	32	2^{12}	4,096
H	L	H	L	L	2^{20}	1,048,576	2^9	512	2^7	128	2^{14}	16,384
H	L	H	L	H	2^{21}	2,097,152	2^9	512	2^7	128	2^{14}	16,384
H	L	H	H	L	2^{22}	4,194,304	Disabled Low		2^9	512	2^{16}	65,536
H	L	H	H	H	2^{23}	8,388,608	Disabled Low		2^9	512	2^{16}	65,536
H	H	L	L	L	2^{24}	16,777,216	2^3	8	2^{11}	2,048	2^{18}	262,144
H	H	L	L	H	2^{25}	33,554,432	2^3	8	2^{11}	2,048	2^{18}	262,144
H	H	L	H	L	2^{26}	67,108,864	2^5	32	2^{13}	8,192	2^{20}	1,048,576
H	H	L	H	H	2^{27}	134,217,728	2^5	32	2^{13}	8,192	2^{20}	1,048,576
H	H	H	L	L	2^{28}	268,435,456	2^7	128	2^{15}	32,768	2^{22}	4,194,304
H	H	H	L	H	2^{29}	536,870,912	2^7	128	2^{15}	32,768	2^{22}	4,194,304
H	H	H	H	L	2^{30}	1,073,741,824	2^9	512	2^{17}	131,072	2^{24}	16,777,216
H	H	H	H	H	2^{31}	2,147,483,648	2^9	512	2^{17}	131,072	2^{24}	16,777,216

'LS294 FUNCTION TABLE

PROGRAMMING INPUTS				FREQUENCY DIVISION			
				Q		TP	
D	C	B	A	BINARY	DECIMAL	BINARY	DECIMAL
L	L	L	L	Inhibit	Inhibit	Inhibit	Inhibit
L	L	L	H	Inhibit	Inhibit	Inhibit	Inhibit
L	L	H	L	2^2	4	2^9	512
L	L	H	H	2^3	8	2^9	512
L	H	L	L	2^4	16	2^9	512
L	H	L	H	2^5	32	2^9	512
L	H	H	L	2^6	64	2^9	512
L	H	H	H	2^7	128	Disabled Low	
H	L	L	L	2^8	256	2^2	4
H	L	L	H	2^9	512	2^3	8
H	L	H	L	2^{10}	1,024	2^4	16
H	L	H	H	2^{11}	2,048	2^5	32
H	H	L	L	2^{12}	4,096	2^6	64
H	H	L	H	2^{13}	8,192	2^7	128
H	H	H	L	2^{14}	16,384	2^8	256
H	H	H	H	2^{15}	32,768	2^9	512

switching loads

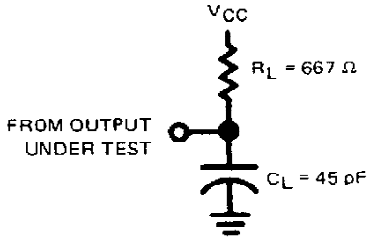
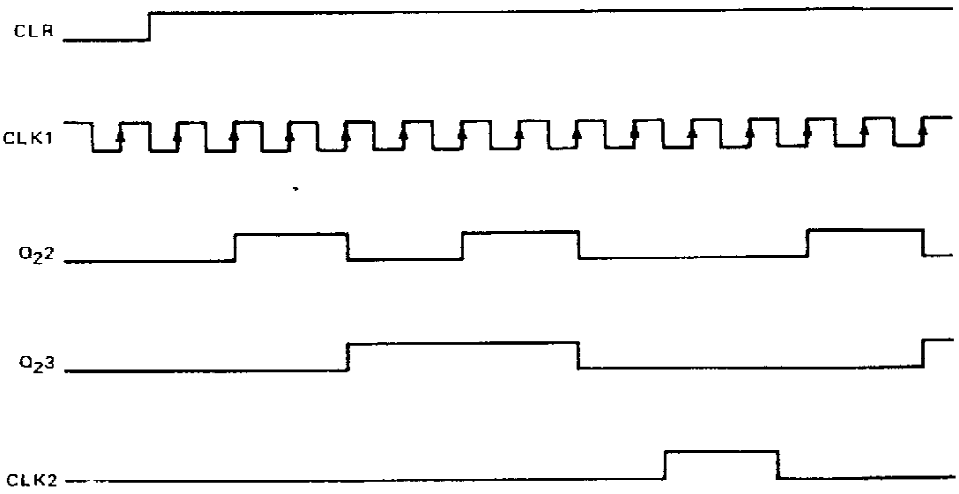


FIGURE 1

'LS292 and 'LS294 timing diagram



SN54290, SN54293, SN54LS290, SN54LS293, SN74290, SN74293, SN74LS290, SN74LS293 DECADE AND 4-BIT BINARY COUNTERS

MARCH 1974 – REVISED MARCH 1988

'290, 'LS290 . . . DECADE COUNTERS
'293, 'LS293 . . . 4-BIT BINARY COUNTERS

- GND and V_{CC} on Corner Pins (Pins 7 and 14 Respectively)

description

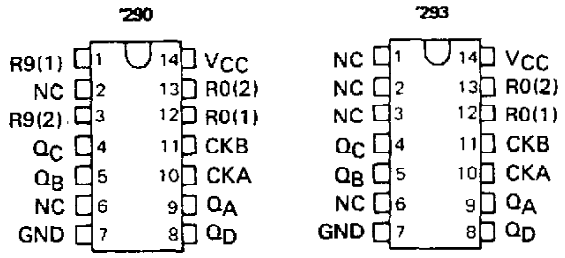
The SN54290/SN74290, SN54LS290/SN74LS290, SN54293/SN74293, and SN54LS293/SN74LS293 counters are electrically and functionally identical to the SN5490A/SN7490A, SN54LS90/SN74LS90, SN5493A/SN7493A, and SN54LS93/SN74LS93, respectively. Only the arrangement of the terminals has been changed for the '290, 'LS290, '293, and 'LS293.

Each of these monolithic counters contains four master-slave flip-flops and additional gating to provide a divide-by-two counter and a three-stage binary counter for which the count cycle length is divide-by-five for the '290 and 'LS290 and divide-by-eight for the '293 and 'LS293.

All of these counters have a gated zero reset and the '290 and 'LS290 also have gated set-to-nine inputs for use in BCD nine's complement applications.

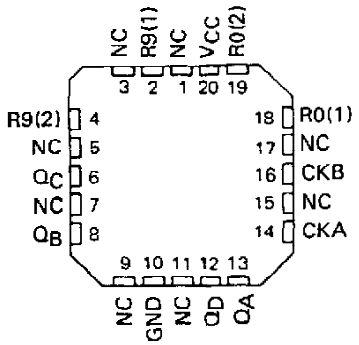
To use the maximum count length (decade or four-bit binary) of these counters, the B input is connected to the Q_A output. The input count pulses are applied to input A and the outputs are as described in the appropriate function table. A symmetrical divide-by-ten count can be obtained from the '290 and 'LS290 counters by connecting the Q_D output to the A input and applying the input count to the B input which gives a divide-by-ten square wave at output Q_A.

SN54290, SN54LS290, SN54293, SN54LS293 . . . J OR W PACKAGE
SN74290, SN74293 . . . N PACKAGE
SN74LS290, SN74LS293 . . . D OR N PACKAGE
(TOP VIEW)

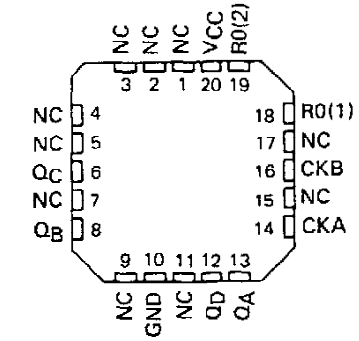


SN54LS290, SN54LS293 . . . FK PACKAGE
(TOP VIEW)

'LS290



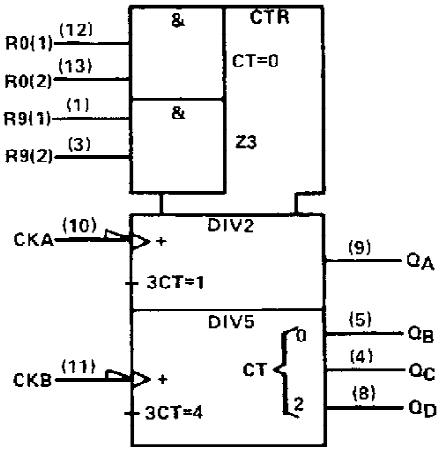
'LS293



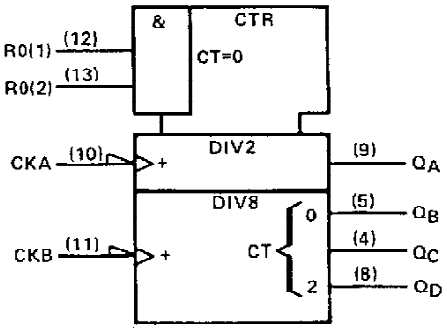
NC – No internal connection

logic symbols†

'290, 'LS290



'293, 'LS293



† These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
Pin numbers shown are for D, J, N, and W packages.

'290, 'LS290
BCD COUNT SEQUENCE
(See Note A)

COUNT	OUTPUT			
	Q_D	Q_C	Q_B	Q_A
0	L	L	L	L
1	L	L	L	H
2	L	L	H	L
3	L	L	H	H
4	L	H	L	L
5	L	H	L	H
6	L	H	H	L
7	L	H	H	H
8	H	L	L	L
9	H	L	L	H

'290, 'LS290
BI-QUINARY (5-2)
(See Note B)

COUNT	OUTPUT			
	Q_A	Q_D	Q_C	Q_B
0	L	L	L	L
1	L	L	L	H
2	L	L	H	L
3	L	L	H	H
4	L	H	L	L
5	H	L	L	L
6	H	L	L	H
7	H	L	H	L
8	H	L	H	H
9	H	H	L	L

'290, 'LS290
RESET/COUNT FUNCTION TABLE

RESET INPUTS				OUTPUT			
$R_{0(1)}$	$R_{0(2)}$	$R_{9(1)}$	$R_{9(2)}$	Q_D	Q_C	Q_B	Q_A
H	H	L	X	L	L	L	L
H	H	X	L	L	L	L	L
X	X	H	H	H	L	L	H
X	L	X	L	COUNT			
L	X	L	X	COUNT			
L	X	X	L	COUNT			
X	L	L	X	COUNT			

'293, 'LS293
RESET/COUNT FUNCTION TABLE

RESET INPUTS		OUTPUT			
$R_{0(1)}$	$R_{0(2)}$	Q_D	Q_C	Q_B	Q_A
H	H	L	L	L	L
L	X	COUNT			
X	L	COUNT			

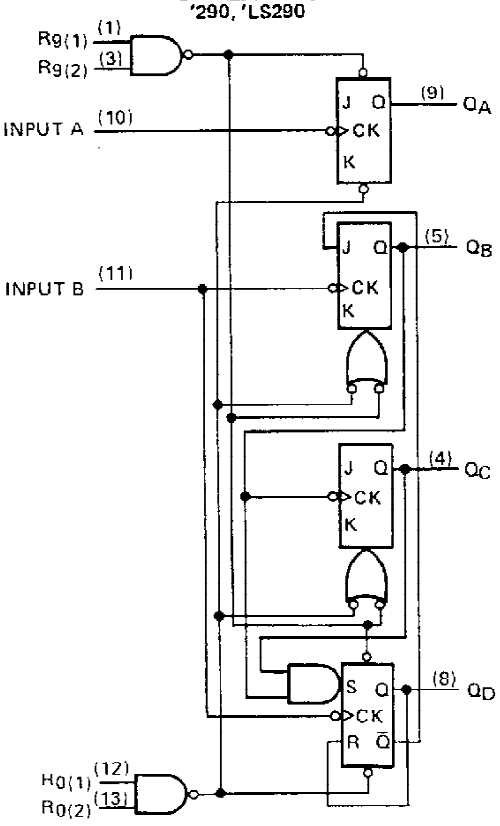
'293, 'LS293
COUNT SEQUENCE
(See Note C)

COUNT	OUTPUT			
	Q_D	Q_C	Q_B	Q_A
0	L	L	L	L
1	L	L	L	H
2	L	L	H	L
3	L	L	H	H
4	L	H	L	L
5	L	H	L	H
6	L	H	H	L
7	L	H	H	H
8	H	L	L	L
9	H	L	L	H
10	H	L	H	L
11	H	L	H	H
12	H	H	L	L
13	H	H	L	H
14	H	H	H	L
15	H	H	H	H

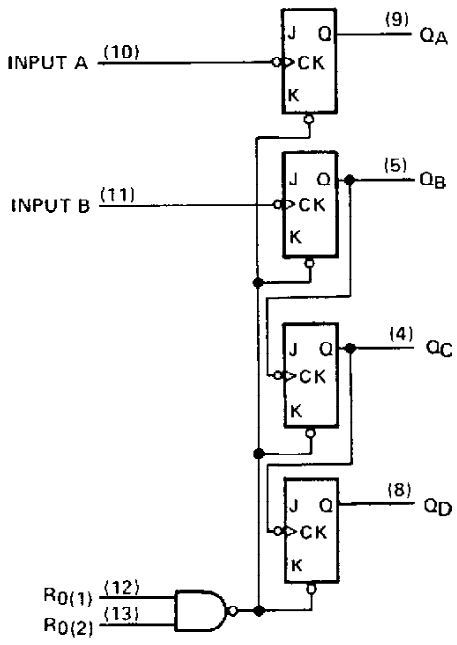
NOTES: A. Output Q_A is connected to input B for BCD count.
B. Output Q_D is connected to input A for bi-quinary count.
C. Output Q_A is connected to input B.
D. H = high level, L = low level, X = irrelevant

logic diagrams (positive logic)

'290, 'LS290

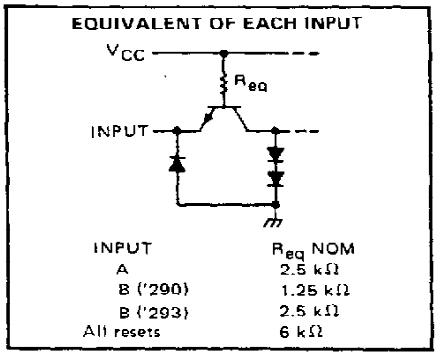


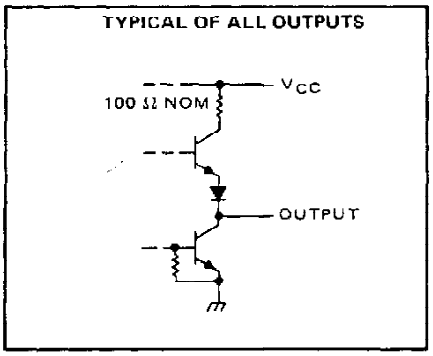
'293, 'LS293



Pin numbers shown are for D, J, N, and W packages.
The J and K inputs shown without connection are for reference only and are functionally at a high level.

schematics of inputs and outputs





absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1) . . . . . 7 V
Input voltage . . . . . 5.5 V
Interemitter voltage (see Note 2) . . . . . 5.5 V
Operating free-air temperature range: SN54' Circuits . . . . . −55°C to 125°C
SN74' Circuits . . . . . 0°C to 70°C
Storage temperature range . . . . . −65°C to 150°C

NOTES: 1. Voltage values, except interemitter voltage, are with respect to network ground terminal.
2. This is the voltage between two emitters of a multiple-emitter transistor. For these circuits, this rating applies between the two R_0 inputs, and for the '290 circuit, it also applies between the two R9 inputs.

recommended operating conditions

		SN54'			SN74'			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V_{CC}		4.5	5	5.5	4.75	5	5.25	V
High-level output current, I_{OH}				−800			−800	μA
Low-level output current, I_{OL}				16			16	mA
Count frequency, f_{count}	A input	0		32	0		32	MHz
	B input	0		16	0		16	
Pulse width, t_w	A input	15			15			ns
	B input	30			30			
	Reset inputs	15			15			
Reset inactive-state setup time, t_{su}		25			25			ns
Operating free-air temperature, T_A		−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER			TEST CONDITIONS†		'290 MIN	'290 TYP‡	'290 MAX	'293 MIN	'293 TYP‡	'293 MAX	UNIT
V_{IH}	High-level input voltage				2			2			V
V_{IL}	Low-level input voltage						0.8			0.8	V
V_{IK}	Input clamp voltage		V_{CC} = MIN, I_I = −12 mA				−1.5			−1.5	V
V_{OH}	High-level output voltage		V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = 0.8 V, I_{OH} = −800 μA		2.4	3.4		2.4	3.4		V
V_{OL}	Low-level output voltage		V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = 0.8 V, I_{OL} = 16 mA¶			0.2	0.4		0.2	0.4	V
I_I	Input current at maximum input voltage		V_{CC} = MAX, V_I = 5.5 V				1			1	mA
I_{IH}	High-level input current	Any reset	V_{CC} = MAX, V_I = 2.4 V				40			40	μA
		A input					80			80	
		B input					120			80	
I_{IL}	Low-level input current	Any reset	V_{CC} = MAX, V_I = 0.4 V				−1.6			−1.6	mA
		A input					−3.2			−3.2	
		B input					−4.8			−3.2	
I_{OS}	Short-circuit output current§		V_{CC} = MAX	SN54'	−20		−57	−20		−57	mA
				SN74'	−18		−57	−18		−57	
I_{CC}	Supply current		V_{CC} = MAX, See Note 3			29	42		26	39	mA

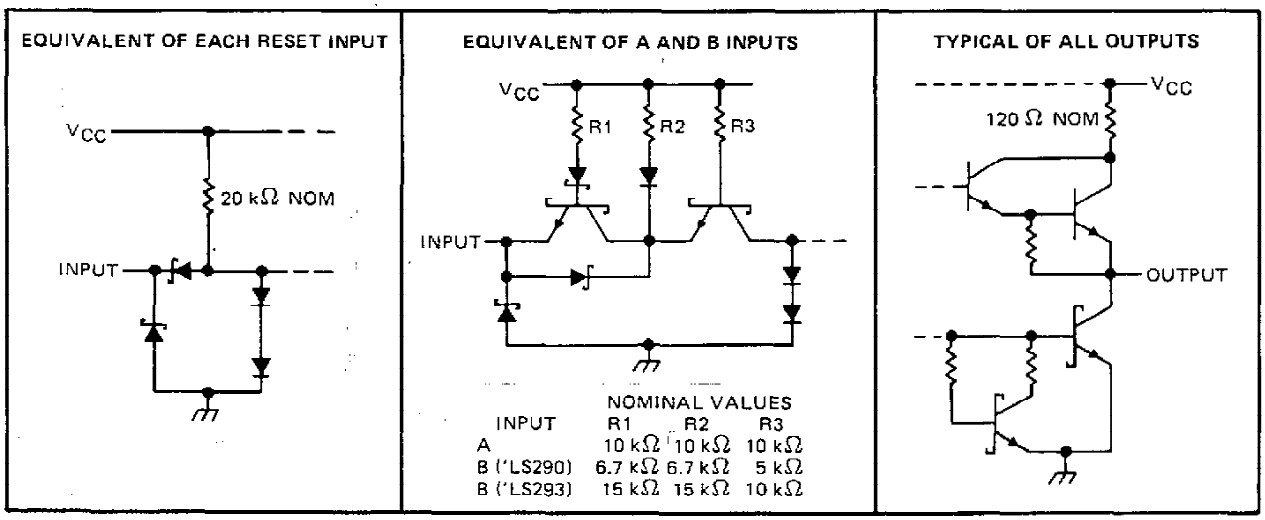
†For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
‡All typical values are at V_{CC} = 5 V, T_A = 25°C.
§Not more than one output should be shorted at a time.
¶Q_A outputs are tested at I_{OL} = 16 mA plus the limit value of I_{IL} for the B input. This permits driving the B input while maintaining full fan-out capability.
NOTE 3: I_{CC} is measured with all outputs open, both R_0 inputs grounded following momentary connection to 4.5 V, and all other inputs grounded.

switching characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER#	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	'290 MIN	'290 TYP	'290 MAX	'293 MIN	'293 TYP	'293 MAX	UNIT
f_{max}	A	Q_A	C_L = 15 pF, R_L = 400 Ω, See Note 4	32	42		32	42		MHz
	B	Q_B		16			16			
t_{PLH}	A	Q_A			10	16		10	16	ns
t_{PHL}					12	18		12	18	
t_{PLH}	A	Q_D			32	48		46	70	ns
t_{PHL}					34	50		46	70	
t_{PLH}	B	Q_B			10	16		10	16	ns
t_{PHL}					14	21		14	21	
t_{PLH}	B	Q_C			21	32		21	32	ns
t_{PHL}					23	35		23	35	
t_{PLH}	B	Q_D			21	32		34	51	ns
t_{PHL}					23	35		34	51	
t_{PHL}	Set-to-0	Any			26	40		26	40	ns
t_{PLH}	Set-to-9	Q_A, Q_D			20	30				ns
t_{PHL}		Q_B, Q_C			26	40				

#f_{max} = maximum count frequency
t_{PLH} = propagation delay time, low-to-high-level output
t_{PHL} = propagation delay time, high-to-low-level output
NOTE 4: Load circuits and voltage waveforms are shown in Section 1.

schematics of inputs and outputs



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 5) . . . . . 7 V
Input voltage: R inputs . . . . . 7 V
A and B inputs . . . . . 5.5 V
Operating free-air temperature range: SN54LS290, SN54LS293 . . . . . −55°C to 125°C
SN74LS290, SN74LS293 . . . . . 0°C to 70°C
Storage temperature range . . . . . −65°C to 150°C

NOTE 5: Voltage values are with respect to network ground terminal.

recommended operating conditions

		SN54LS'			SN74LS'			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V_{CC}		4.5	5	5.5	4.75	5	5.25	V
High-level output current, I_{OH}				−400			−400	μA
Low-level output current, I_{OL}				4			8	mA
Count frequency, f_{count}	A input	0		32	0		32	MHz
	B input	0		16	0		16	
Pulse width, t_w	A input	15			15			ns
	B input	30			30			
	Reset inputs	30			30			
Reset inactive-state setup time, t_{su}		25			25			ns
Operating free-air temperature, T_A		−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER			TEST CONDITIONS†			SN54LS' MIN	SN54LS' TYP‡	SN54LS' MAX	SN74LS' MIN	SN74LS' TYP‡	SN74LS' MAX	UNIT
V_{IH}	High-level input voltage					2			2			V
V_{IL}	Low-level input voltage							0.7			0.8	V
V_{IK}	Input clamp voltage		V_{CC} = MIN,	I_I = −18 mA				−1.5			−1.5	V
V_{OH}	High-level output voltage		V_{CC} = MIN, V_{IL} = V_{IL} max,	V_{IH} = 2 V, I_{OH} = −400 μA		2.5	3.4		2.7	3.4		V
V_{OL}	Low-level output voltage		V_{CC} = MIN, V_{IL} = V_{IL} max	V_{IH} = 2 V,	I_{OL} = 4 mA¶		0.25	0.4		0.25	0.4	V
					I_{OL} = 8 mA¶					0.35	0.5	
I_I	Input current at maximum input voltage	Any reset	V_{CC} = MAX,	V_I = 7 V				0.1			0.1	mA
		A input	V_{CC} = MAX,	V_I = 5.5 V				0.2			0.2	
		B of 'LS290						0.4			0.4	
		B of 'LS293						0.2			0.2	
I_{IH}	High-level input current	Any reset	V_{CC} = MAX,	V_I = 2.7 V				20			20	μA
		A input						40			40	
		B of 'LS290						80			80	
		B of 'LS293						40			40	
I_{IL}	Low-level input current	Any reset	V_{CC} = MAX,	V_I = 0.4 V				−0.4			−0.4	mA
		A input						−2.4			−2.4	
		B of 'LS290						−3.2			−3.2	
		B of 'LS293						−1.6			−1.6	
I_{OS}	Short-circuit output current§		V_{CC} = MAX			−20		−100	−20		−100	mA
I_{CC}	Supply current		V_{CC} = MAX,	See Note 3	'LS290		9	15		9	15	mA
					'LS293		9	15		9	15	

†For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
‡All typical values are at V_{CC} = 5 V, T_A = 25°C.
§Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.
¶Q_A outputs are tested at specified I_{OL} plus the limit value of I_{IL} for the B input. This permits driving the B input while maintaining full fan-out capability.
NOTE 3: I_{CC} is measured with all outputs open, both R_0 inputs grounded following momentary connection to 4.5 V, and all other inputs grounded.

switching characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER#	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	'LS290 MIN	'LS290 TYP	'LS290 MAX	'LS293 MIN	'LS293 TYP	'LS293 MAX	UNIT
f_{max}	A	Q_A	C_L = 15 pF, R_L = 2 kΩ, See Note 4	32	42		32	42		MHz
	B	Q_B		16			16			
t_{PLH}	A	Q_A			10	16		10	16	ns
t_{PHL}					12	18		12	18	
t_{PLH}	A	Q_D			32	48		46	70	ns
t_{PHL}					34	50		46	70	
t_{PLH}	B	Q_B			10	16		10	16	ns
t_{PHL}					14	21		14	21	
t_{PLH}	B	Q_C			21	32		21	32	ns
t_{PHL}					23	35		23	35	
t_{PLH}	B	Q_D			21	32		34	51	ns
t_{PHL}					23	35		34	51	
t_{PHL}	Set-to-0	Any			26	40		26	40	ns
t_{PLH}	Set-to-9	Q_A, Q_D			20	30				ns
t_{PHL}		Q_B, Q_C			26	40				

#f_{max} = maximum count frequency
t_{PLH} = propagation delay time, low-to-high-level output
t_{PHL} = propagation delay time, high-to-low-level output
NOTE 4: Load circuits and voltage waveforms are shown in Section 1.

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